Search Notes



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ATIAS ET AL.

Reexamination

Applicant(s)/Patent Under

Examiner

Art Unit

Trujillo, James K

2116

SEARCHED

| Class | Subclass | Date | Examiner |
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| 713 | 340 | 5/15/07 | JKT |

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| EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP | 11/22/06 | JKT |
| Updated - see attached | 4/16/07 | JKT |
| Updated - see attached; interference search in claims, see history | 5/14/07 | JKT |

INTERFERENCE SEARCH

| · Class | Subclass | Date | Examiner |
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